Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

10633884

KRAISS ET AL.

Examiner

Nguyen, Phillip H

Art Unit 2191

Notes	Date	Examiner	
EAST: TEXT SEARCH, CLASS SEARCH (717 AND 707), INVENTOR SEARCH FOR DOUBLE PATENTING. SEARCH HISTORY IS ENCLOSED. CONSULTED WITH WEI ZHEN ABOUT 101 PROBLEM.	11/6/2006	PHILLIP NGUYEN H.	
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